

Notice of References Cited	Application/Control No. 10/519,846		Applicant(s)/Patent Under Reexamination KIM ET AL.	
	Examiner DARREN B. SCHWARTZ		Art Unit 4193	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0114466 A1	08-2002	Tanaka et al.	380/232
*	B	US-2002/0184515 A1	12-2002	Oho et al.	713/193
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	I	US-			
	J	US-			
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

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